Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,399	SHIH-CHIEH ET AL.	
Examiner	Art Unit	
Vincent T. Tran	2115	

	SEARCHED				
Class	Subclass	Date	Examiner		
*					
		,			
			·		

;					
	<u> </u>	L			

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	_				

SEARCH (INCLUDING SEAR	NOTES ICH STRATEGY)
	DATE	EXMR
Updated Search EAST - see attachment	7/19/2006	VT
w		
	·	